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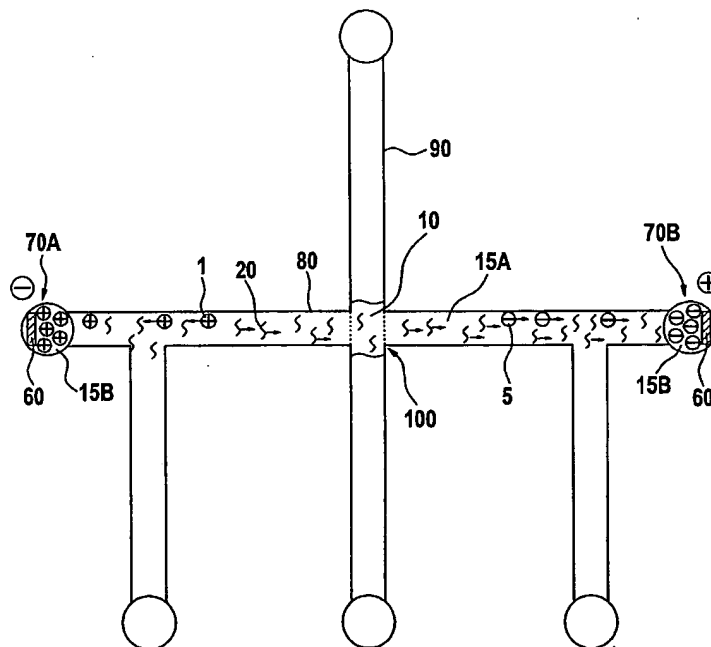
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(54) Title: **CHARGED PARTICLE REDUCTION IN ANALYTE PROCESSING**



(57) Abstract: The invention discloses a method for processing analytes (20) in a first solution (15A) also containing charged particles (1, 5), the first solution being in a compartment, comprising the method steps of subjecting said compartment to an electric field, thereby reducing the amount of the charged particles (1, 5) in a part (10) of the first solution 15A, which is located in a section of the compartment, and subjecting said part (10) of the first solution obtained in step A) containing the analytes (20) to further processing.



WO 2005/075971 A1